

<b>Notice of References Cited</b>	Application/Control No. 10/029,779		Applicant(s)/Patent Under Reexamination HEIDEMANN ET AL.	
	Examiner L Blaine Lankford		Art Unit 1651	Page 1 of 1

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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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X	U	Whitaker et al., Journal of the American Chemical Society, pages 28-43, 1998.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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